

Docket No. 245199US90CONT



IPW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Yasuji HIRAMATSU, et al.

SERIAL NO: 10/718,535

GAU: 1725

FILED: November 24, 2003

EXAMINER:

FOR: SEMICONDUCTOR-PRODUCING/EXAMINING DEVICE

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- ☐ The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- ☒ Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

- ☒ Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,
MAIER & NEUSTADT, P.C.


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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 245199US90CONT		SERIAL NO. 10/718,535	
LIST OF REFERENCES CITED BY APPLICANT 				APPLICANT Yasuji HIRAMATSU, et al.			
				FILING DATE November 24, 2003		GROUP 1725	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA	2003-0104186	06/05/03	ITO			
	AB	2001-0040158	11/15/01	SAITO et al.			
	AC	2001-0042745	11/22/01	SAITO et al.			
	AD	2002-0043527	04/18/02	ITO			
	AE	2002-0043528	04/18/02	ITO			
	AF	2002-0043530	04/18/02	ITO			
	AG	2003-0000937	01/02/03	ITO			
	AH	2003-0136776	07/24/03	ITO			
	AI	2003-0015521	01/23/03	ITO			
	AJ	2002-0180466	12/05/02	HIRAMATSU et al.			
	AK	2003-0080110	05/01/03	HIRAMATSU et al.			
	AL	2002-0190054	12/19/02	ITO et al.			
	AM	2003-0038129	02/27/03	HIRAMATSU et al.			
	AN	2002-0179592	12/05/02	HIRAMATSU et al.			
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO			
	AO						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				Date Considered			

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	AA	2003-0062358	04/03/03	ITO et al.			
	AB	2003-0015515	01/23/03	ITO et al.			
	AC	2004-0026402	02/12/04	ITO et al.			
	AD	2003-0102299	06/05/03	ITO et al.			
	AE	2003-0098299	05/29/03	HIRAMATSU et al.			
	AF	2003-0132218	07/17/03	HIRAMATSU et al.			
	AG	2003-0132217	07/17/03	ITO et al.			
	AH	2004-0021475	02/05/04	ITO et al.			
	AI	2004-0026403	02/12/04	KARIYA et al.			
	AJ	2004-0060925	04/01/04	ZHOU et al.			
	AK	2003-0170415	09/11/03	HIRAMATSU et al.			
	AL	2003-0198004	10/23/03	HIRAMATSU et al.			
	AM	2004-0117977	06/24/04	HIRAMATSU et al.			
	AN	2003-0203225	10/30/03	HIRAMATSU et al.			
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	AA	2003-0044589	03/06/03	NIWA			
	AB	2004-0007773	01/15/04	HIRAMATSU et al.			
	AC	2004-0011782	01/22/04	ITO et al.			
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	AE	2004-0016746	01/29/04	ITO et al.			
	AF	2004-0035846	02/26/04	HIRAMATSU et al.			
	AG	2004-0065881	04/08/04	ITO			
	AH	2003-0054147	03/20/03	NIWA			
	AI	2004-0142153	07/22/04	NIWA			
	AJ	2004-0045951	03/11/04	ITO et al.			
	AK	2004-0206747	10/21/04	ITO			
	AL	2004-0060920	04/01/04	ITO et al.			
	AM	6,710,307	03/23/04	ITO et al.			
	AN	2004-0152582	08/05/04	ITO et al.			
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	AC						
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LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Patent Appl. Publication No.</u>	<u>Inventor/ Applicant</u>
PER CLIENT	10/345,356	01/16/03	2003-0104186	ITO
PER CLIENT	09/880,742	06/13/01	2001-0040158	SAITO et al.
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221015US90 PCT	10/070,441	06/26/02	2003-0062358	ITO et al.
221158US90 PCT	10/088,098	05/30/02	2003-0015515	ITO et al.
221689US90 DIV	6,710,307	03/23/04		ITO et al.
222661US90 PCT	10/111,980	06/27/02	2004-0026402	ITO et al.
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*Present Application; listed for information

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233544US90 PCT	10/343,747	08/27/03	2004-0021475	ITO et al.
233936US90 PCT	10/344,148	07/29/03	2004-0026403	KARIYA et al.
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234652US90 CONT	10/386,615	03/13/03	2003-0170415	HIRAMATSU et al.
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237250US90 CONT	10/442,967	05/22/03	2003-0203225	HIRAMATSU et al.
237387US90 CONT	10/260,360	10/01/02	2003-0044589	NIWA
237457US90 CONT	10/615,950	07/10/03	2004-0007773	HIRAMATSU et al.
238745US90 CONT	10/618,651	07/15/03	2004-0011782	ITO et al.
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238755US90 CONT	10/618,655	07/15/03		ITO et al.
238761US90 CONT	10/618,665	07/15/03	2004-0016746	ITO et al.
239930US90 PCT	10/380,327	05/08/03	2004-0035846	HIRAMATSU et al.
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241064US90 CONT	10/244,008	09/16/02	2003-0054147	NIWA
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*Present Application; listed for information
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257055US90 CONT	10/916,405	08/12/04		HIRAMATSU et al.
257463US90 CONT	10/921,992	08/20/04		HIRAMATSU et al.
257487US90 CONT	10/921,271	08/19/04		HIRAMATSU et al.
260454US90 CONT	10/969,945	10/22/04		ITO et al.

*Present Application; listed for information

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